<u>MOSFET</u> – Power, Single N-Channel 80 V, 3.7 mΩ, 123 A

Features

- Small Footprint (5x6 mm) for Compact Design
- Low R_{DS(on)} to Minimize Conduction Losses
- Low Q_G and Capacitance to Minimize Driver Losses
- NVMFS6H818NWF Wettable Flank Option for Enhanced Optical Inspection
- AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free and are RoHS Compliant

MAYIMI IM DATINGS /T 05°C uploss otherwise noted)



ON Semiconductor®

www.onsemi.com

V _{(BR)DSS}	R _{DS(ON)} MAX	I _D MAX
80 V	$3.7~\mathrm{m}\Omega$ @ 10 V	123 A

D (5,6)

MAXIMUM RATINGS (T _J = 25°C unless otherwise noted)							
Parameter			Value	Unit			
Drain-to-Source Voltage			80	V			
ate-to-Source Voltage			±20	V			
Steady	$T_{C} = 25^{\circ}C$	۱ _D	123	А			
	T _C = 100°C		87				
State	$T_{C} = 25^{\circ}C$	PD	136	W			
	$T_{\rm C} = 100^{\circ}{\rm C}$		68				
	$T_A = 25^{\circ}C$	۱ _D	20	А			
Steady State	T _A = 100°C		14				
	$T_A = 25^{\circ}C$	PD	3.8	W			
	T _A = 100°C		1.9				
T _A = 25	°C, t _p = 10 μs	I _{DM}	900	А			
$\label{eq:source} \begin{array}{c} \mbox{Operating Junction and Storage Temperature} \\ \mbox{Source Current (Body Diode)} \\ \mbox{Single Pulse Drain-to-Source Avalanche} \\ \mbox{Energy (I}_{L(pk)} = 9.3 \mbox{ A}) \end{array}$			–55 to + 175	°C			
			113	А			
			731	mJ			
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			260	°C			
	neter e Steady State Steady State $T_A = 25$ Storage T biode) Source Av- oldering F	neter e T _C = 25°C T _C = 100°C T _A = 25°C T _A = 100°C	Symbol e Symbol e V _{DSS} a $T_C = 25^{\circ}C$ Ip Steady $T_C = 100^{\circ}C$ Ip Steady $T_C = 100^{\circ}C$ Pp T_C = 100^{\circ}C Tp Steady $T_A = 25^{\circ}C$ Ip Steady $T_A = 25^{\circ}C$ Ip T_A = 100^{\circ}C Tp Ip T_A = 25^{\circ}C, t_p = 10 \mu s Ip Storage Temperature Tj, Tstg biode) Is Source Avalanche EAS oldering Purposes TL	Symbol Value e V _{DSS} 80 e V _{DSS} 80 e V _{GS} ± 20 steady T _C = 25°C I _D 123 Steady T _C = 100°C R7 87 T _C = 100°C PD 136 68 T _A = 25°C PD 136 14 T _A = 25°C PD 3.8 1.9 T _A = 25°C PD 3.8 1.9 T _A = 100°C I _{DM} 900 3.8 1.9 T _A = 25°C, t _p = 10 µs I _{DM} 900 3.8 1.9 T _A = 25°C, t _p = 10 µs I _{DM} 900 3.8 1.9 Storage Temperature I _S 113 3.8 3.8 3.1 Source Avalanche E _{AS} 731 3.1 oldering Purposes			

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

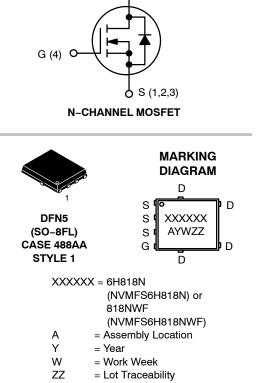
THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case - Steady State	$R_{\theta JC}$	1.1	°C/W
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta JA}$	39	

1. The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.

2. Surface-mounted on FR4 board using a 650 mm², 2 oz. Cu pad.

3. Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.



ORDERING INFORMATION

See detailed ordering, marking and shipping information in the package dimensions section on page 5 of this data sheet.

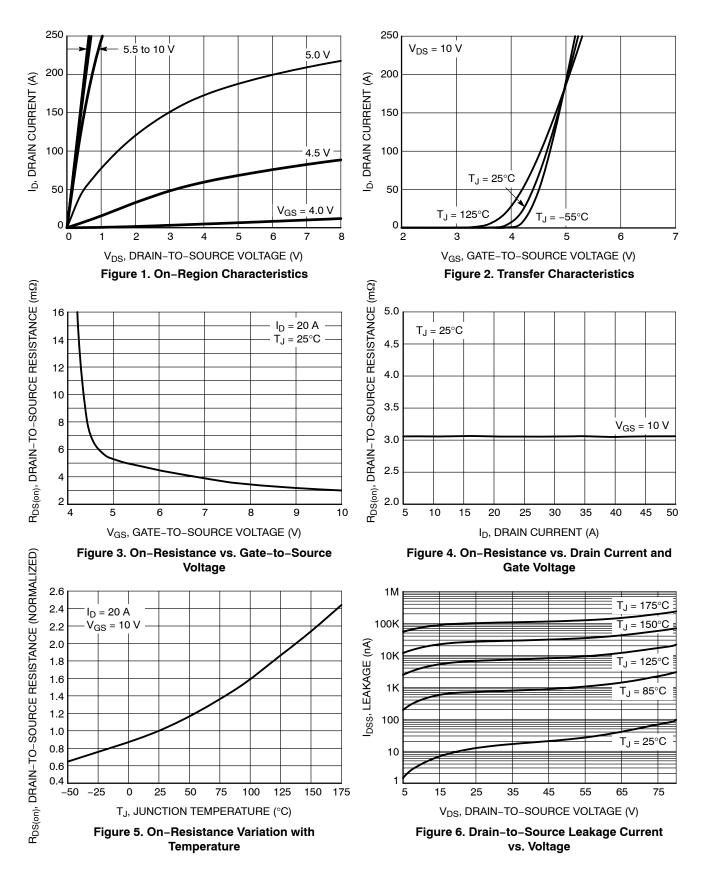
ELECTRICAL CHARACTERISTICS (T_J = $25^{\circ}C$ unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit	
OFF CHARACTERISTICS	-							
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	V_{GS} = 0 V, I_D = 250 μ A		80			V	
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} / TJ				39		mV/°C	
Zero Gate Voltage Drain Current	I _{DSS}	$V_{GS} = 0 V, T_{J} = 25^{\circ}C$				10		
		V _{DS} = 80 V	T _J = 125°C			100	μA	
Gate-to-Source Leakage Current	I _{GSS}	$V_{DS} = 0 V, V_{GS} = 20 V$				100	nA	
ON CHARACTERISTICS (Note 4)								
Gate Threshold Voltage	V _{GS(TH)}	V _{GS} = V _{DS} , I _D	= 190 μA	2.0		4.0	V	
Threshold Temperature Coefficient	V _{GS(TH)} /T _J				7.0		mV/°C	
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 20 A		3.1	3.7	mΩ	
Forward Transconductance	9 _{FS}	V _{DS} =15 V, I _D = 50 A			170		S	
CHARGES, CAPACITANCES & GATE RE	SISTANCE			-				
Input Capacitance	C _{ISS}	$V_{GS} = 0 \text{ V}, \text{ f} = 1 \text{ MHz}, V_{DS} = 40 \text{ V}$ $V_{GS} = 10 \text{ V}, V_{DS} = 40 \text{ V}; \text{ I}_{D} = 50 \text{ A}$			3100		pF	
Output Capacitance	C _{OSS}				440			
Reverse Transfer Capacitance	C _{RSS}				20			
Total Gate Charge	Q _{G(TOT)}				46			
Threshold Gate Charge	Q _{G(TH)}	V _{GS} = 10 V, V _{DS} = 40 V; I _D = 50 A			9.0		nC	
Gate-to-Source Charge	Q _{GS}				15			
Gate-to-Drain Charge	Q _{GD}				8.0			
Plateau Voltage	V _{GP}				5.0		V	
SWITCHING CHARACTERISTICS (Note 5	5)			-				
Turn-On Delay Time	t _{d(ON)}	V_{GS} = 10 V, V_{DS} = 64 V, I _D = 50 A, R _G = 2.5 Ω			22		- ns	
Rise Time	tr				98			
Turn-Off Delay Time	t _{d(OFF)}				49			
Fall Time	t _f				21			
DRAIN-SOURCE DIODE CHARACTERIS	TICS			-				
Forward Diode Voltage	V _{SD}	V _{GS} = 0 V,	$T_J = 25^{\circ}C$		0.8	1.2		
		$I_{\rm S} = 20 \rm{A}$	T _J = 125°C		0.7		V	
Reverse Recovery Time	t _{RR}	V _{GS} = 0 V, dIS/dt = 100 A/µs, I _S = 50 A			63		ns	
Charge Time	ta				31			
Discharge Time	t _b				32			
Reverse Recovery Charge	Q _{RR}				55		nC	

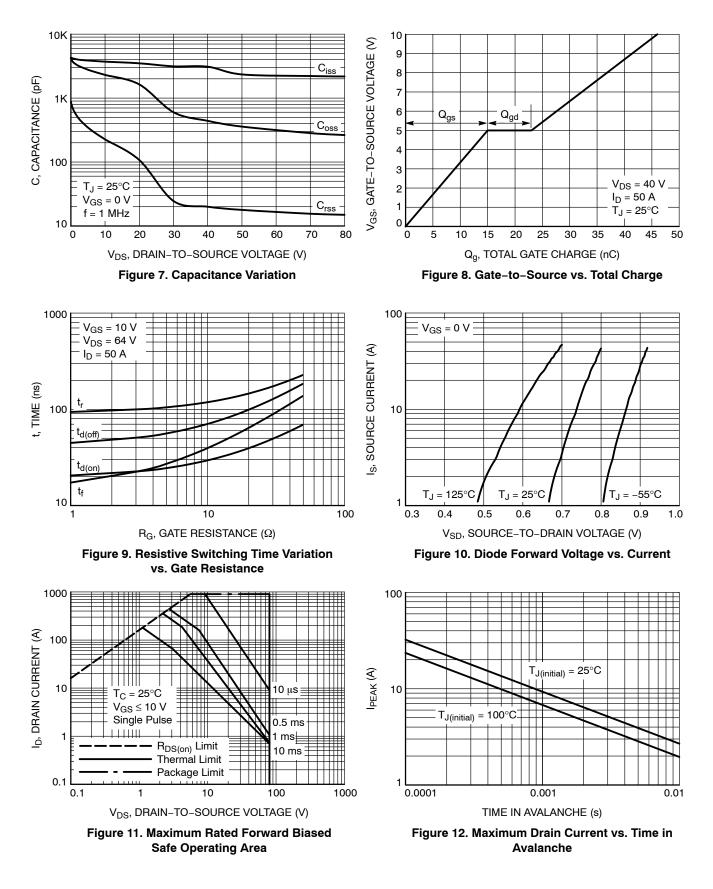
Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions. 4. Pulse Test: pulse width $\leq 300 \ \mu$ s, duty cycle $\leq 2\%$.

5. Switching characteristics are independent of operating junction temperatures.

TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS

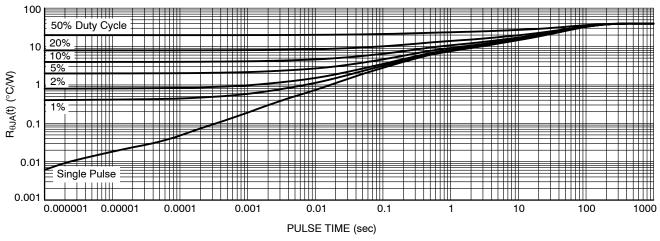


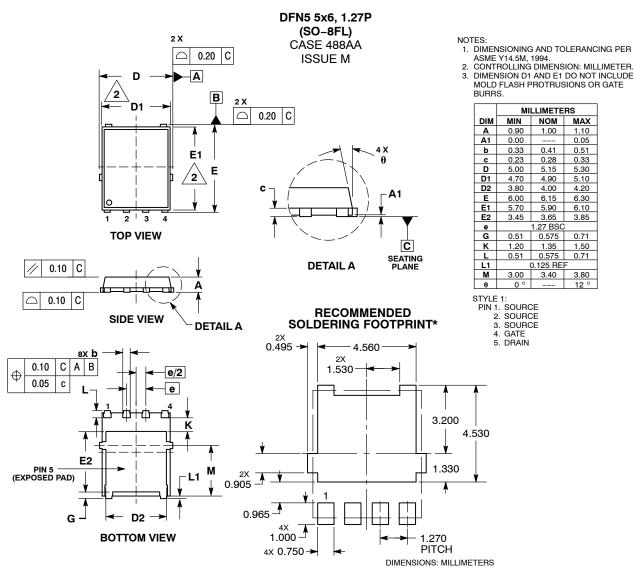
Figure 13. Thermal Response

DEVICE ORDERING INFORMATION

Device	Marking	Package	Shipping [†]
NVMFS6H818NT1G	6H818N	DFN5 (Pb–Free)	1500 / Tape & Reel
NVMFS6H818NWFT1G	818NWF	DFN5 (Pb-Free, Wettable Flanks)	1500 / Tape & Reel

+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

PACKAGE DIMENSIONS



*For additional information on our Pb–Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

ON Semiconductor and are trademarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor owns me rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of ON Semiconductor's product/patent coverage may be accessed at www.onsemi.com/site/pdt/Patent-Marking.pdf. ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does ON Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using ON Semiconductor products, "ripcical" parameters which may be provided in ON Semiconductor data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. ON Semiconductor does not convey any license under its patent rights or the rights of others. ON Semiconductor products are not designed, intended, or authorized for use as a critical component in life support systems or any FDA Class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer purchase or use ON Semiconductor products for any such unintended or unauthorized application, Buyer shall indemnify and hold ON Semiconductor and its officers, employees, subsidiaries, affiliates, and distributors harmless against all claims, costs, damages, and expenses, and reasonable attorney fees arising out of, directly or indirectly, any claim of

PUBLICATION ORDERING INFORMATION

LITERATURE FULFILLMENT:

Literature Distribution Center for ON Semiconductor 19521 E. 32nd Pkwy, Aurora, Colorado 80011 USA Phone: 303-675-2175 or 800-344-3860 Toll Free USA/Canada Fax: 303-675-2176 or 800-344-3867 Toll Free USA/Canada Email: orderlit@onsemi.com N. American Technical Support: 800–282–9855 Toll Free USA/Canada Europe, Middle East and Africa Technical Support:

Phone: 421 33 790 2910 Japan Customer Focus Center Phone: 81-3-5817-1050 ON Semiconductor Website: www.onsemi.com

Order Literature: http://www.onsemi.com/orderlit

For additional information, please contact your local Sales Representative